

HY15P03C2-VB Datasheet P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)			
- 30	0.0032 at V _{GS} = - 10 V	- 100	78 nC			
- 30	0.0050 at V _{GS} = - 4.5 V	- 80	76110			

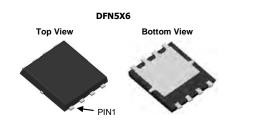
FEATURES

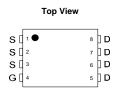
- Halogen-free
- Trench Power MOSFET
- 100 % R_g Tested

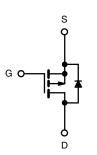


APPLICATIONS

- Notebook
 - Load Switch







P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	$T_A = 25 ^{\circ}C$, unles	ss otherwise not	ed	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	- 30	V	
Gate-Source Voltage	V _{GS}	± 20	v	
	T _C = 25 °C		- 100	
Continuous Drain Current (T _{,I} = 150 °C)	T _C = 70 °C	₋	- 75	
Continuous Diam Current (1) = 150 °C)	T _A = 25 °C	I _D	- 31.6 ^{b, c}	
	T _A = 70 °C		- 25.3 ^{b, c}	A
Pulsed Drain Current	Pulsed Drain Current			7
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	- 60 ^a	
Continuous Source-Drain Diode Current	T _A = 25 °C	'S	- 5.6 ^{b, c}	
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	- 40	
Single Pulse Avalanche Energy	L = 0.111111	E _{AS}	80	mJ
	T _C = 25 °C		104	
Maximum Power Dissipation	T _C = 70 °C	P _D	66.6	w
Maximum i ower bissipation	T _A = 25 °C	, p	6.25 ^{b, c}	
	T _A = 70 °C		4.0 ^{b, c}	
Operating Junction and Storage Temperature Rar	T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature)		260		

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R _{thJA}	15	20	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	0.9	1.2] 5/**		

Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. The DFN5x6 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 54 °C/W.

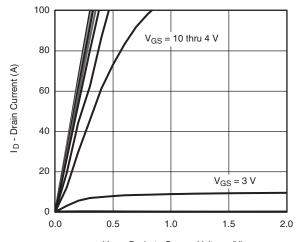


SPECIFICATIONS T _J = 25 °C, unless otherwise noted								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
Static								
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	- 30			V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 31		mV/°C		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1D = - 250 μΑ		6.5				
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1.0		- 3.0	V		
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA		
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			- 1 - 10	μΑ		
On-State Drain Current ^a	I _{D(on)}	V _{DS} = - 5 V, V _{GS} = - 10 V	- 30			Α		
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = -10 \text{ V}, I_D = -20 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -15 \text{ A}$		0.0032		Ω		
Converd Transport dust and a	9 _{fs}	$V_{DS} = -15 \text{ V}, I_D = -20 \text{ A}$		95		S		
Forward Transconductance ^a	9ts	VDS = -13 V, 1D = -20 A		95				
Dynamic ^b				0050		1		
Input Capacitance	C _{iss}	V 45VV 0V4 4MI-		8650		pF		
Output Capacitance	Coss	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		1215				
Reverse Transfer Capacitance	C _{rss}	V 45 V V 40 V I 90 4		1125				
Total Gate Charge	Qg	$V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -20 \text{ A}$		167 78	250 120			
Gate-Source Charge	Q _{gs}	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -20 \text{ A}$		27		nC		
Gate-Drain Charge	Q_{gd}			35				
Gate Resistance	R_{g}	f = 1 MHz		1.7		Ω		
Turn-On Delay Time	t _{d(on)}			25	40			
Rise Time	t _r	V_{DD} = - 15 V, R_L = 15 Ω		15	30			
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ - 1.0 A, V_{GEN} = - 10 V, R_g = 1 Ω		110	170			
Fall Time	t _f			30	50			
Turn-On Delay Time	t _{d(on)}			110	170	ns		
Rise Time	t _r	V_{DD} = - 15 V, R_L = 15 Ω		100	150	- - -		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ - 1.0 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		100	150			
Fall Time	t _f			50	75			
Drain-Source Body Diode Characteristic	es			•				
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			60			
Pulse Diode Forward Current ^a	I _{SM}				100	A		
Body Diode Voltage	V _{SD}	I _S = - 5 A		- 0.74	- 1.1	V		
Body Diode Reverse Recovery Time	t _{rr}			50	100	ns		
Body Diode Reverse Recovery Charge	Q _{rr}	L 25 A dl/dt 100 A/::- T 25 20		65	130	nC		
Reverse Recovery Fall Time	t _a	$I_F = 3.5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		26				
Reverse Recovery Rise Time	t _b			24		ns		

- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

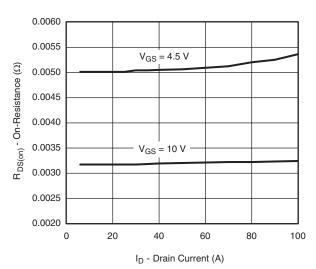
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



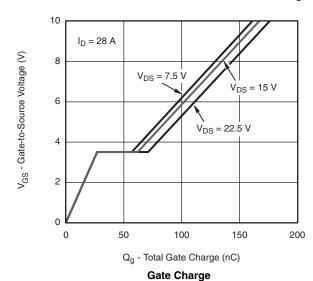


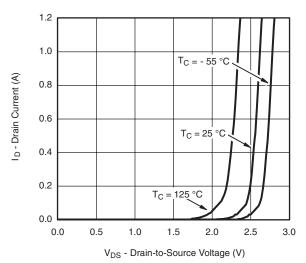
V_{DS} - Drain-to-Source Voltage (V)

Output Characteristics

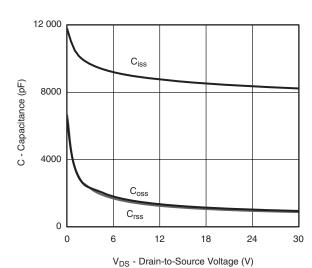


On-Resistance vs. Drain Current and Gate Voltage

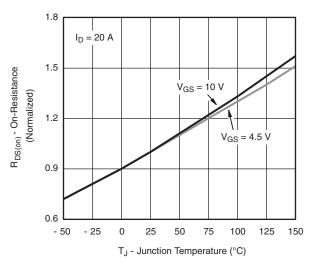




Transfer Characteristics

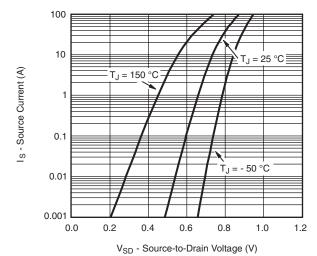


Capacitance

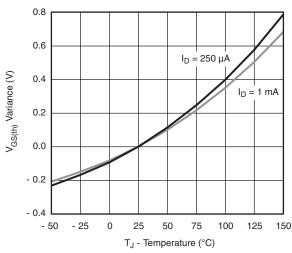


On-Resistance vs. Junction Temperature



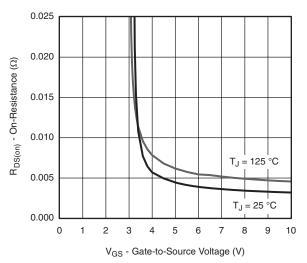


Source-Drain Diode Forward Voltage

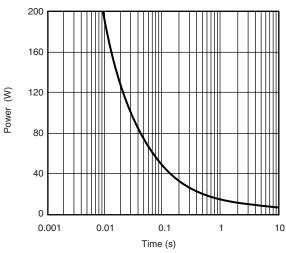


Threshold Voltage

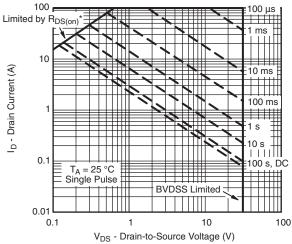
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On-Resistance vs. Gate-to-Source Voltage



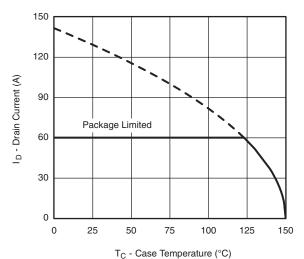
Single Pulse Power, Junction-to-Ambient



* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

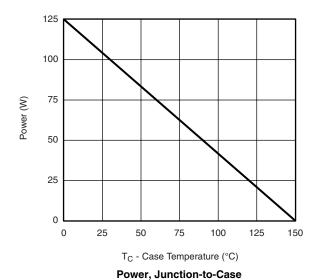
Safe Operating Area, Junction-to-Ambient

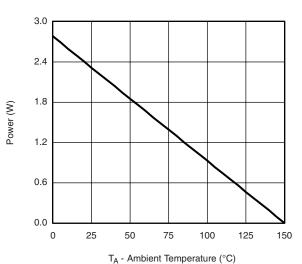




C - Case Temperature (C)

Current Derating*

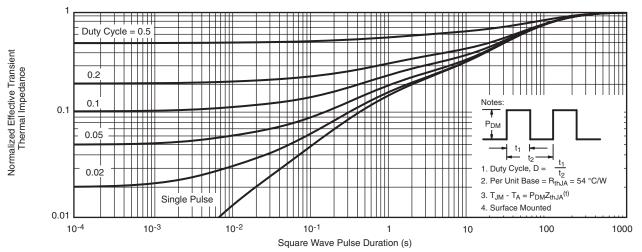




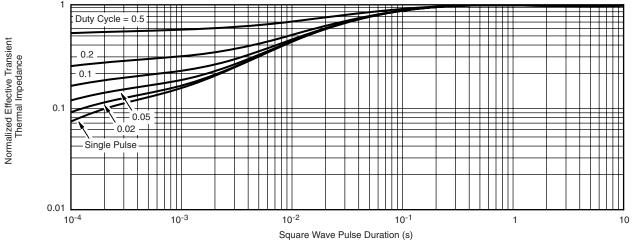
Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





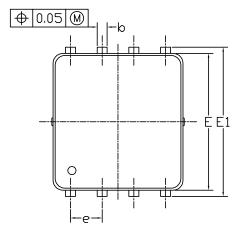
Normalized Thermal Transient Impedance, Junction-to-Ambient

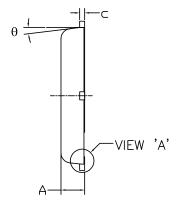


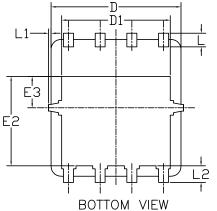
Normalized Thermal Transient Impedance, Junction-to-Case

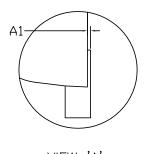


DFN5x6_8L_EP1_P PACKAGE OUTLIN



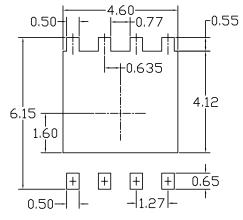






<u>VIEW 'A'</u> (SCALE 5:1)

RECOMMENDED LAND PATTERN



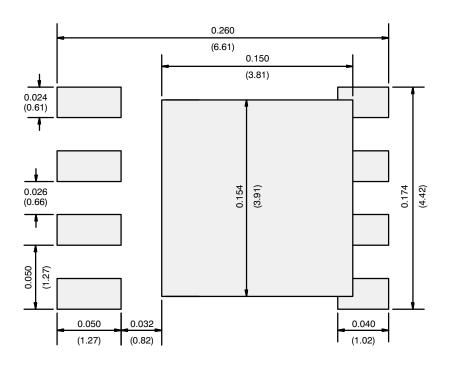
DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES				
SYMBOLS	MIN	NOM	MAX	MIN	NOM	MAX	
A	0.85	0. 95	1.00	0.033	0.037	0.039	
A1	0.00		0.05	0.000		0.002	
b	0.30	0.40	0.50	0.012	0.016	0.020	
c	0. 15	0. 20	0. 25	0.006	0.008	0.010	
D	5. 10	5. 20	5. 30	0. 201	0. 205	0. 209	
D1	4. 25	4. 35	4. 45	0. 167	0.171	0. 175	
Е	5. 45	5. 55	5. 65	0. 215	0. 219	0. 222	
E1	5. 95	6.05	6. 15	0. 234	0. 238	0. 242	
E2	3. 525	3. 625	3. 725	0.139	0. 143	0. 147	
E3	1. 175	1. 275	1. 375	0.046	0.050	0.054	
e	1. 27 BSC			0.050 BSC			
L	0.45	0. 55	0.65	0.018	0.022	0.026	
L1	0		0.15	0		0.006	
L2	0.68 REF			0. 027 REF			
θ	0°		10°	0°		10°	

NOTE

- UNIT: mm
- 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



RECOMMENDED MINIMUM PADS FOR DFN5 x 6



Recommended Minimum Pads Dimensions in Inches/(mm)



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